

**Search Notes**

Application/Control No.

10/714,654

Examiner

Randolph Chu

Applicant(s)/Patent under  
Reexamination

TAKEKOSHI ET AL.

Art Unit

2624

**SEARCHED**

Class	Subclass	Date	Examiner
382	128	6/6/2007	RIC
705	2	6/6/2007	RIC
705/	3	6/6/2007	RIC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	6/6/2007	RIC
Inventor Name Search	6/6/2007	RIC
Consult with Wenpeng Chen	6/6/2007	ric